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Inorganic Chemistry Communications



journal homepage: www.elsevier.com/locate/inoche

Trimethylphosphite stabilized N-silver(I) succinimide complexes as CVD precursors

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ARTICLE INFO

Article history: Received 4 August 2010 Accepted 21 October 2010 Available online 28 October 2010

Keywords: Silver Succinimide Precursor MOCVD Deposition Trimethylphosphite

ABSTRACT

The preparation of $[(MeO)_3P_n \cdot AgNC_4H_4O_2]$ (n = 1, 2a; n = 2, 2b) is described. The molecular structure of 2a was determined by using X-ray single crystal analysis. Complex 2b was tested as Metal Organic Chemical Vapor Deposition (MOCVD) precursor in the deposition of silver for the first time. The thin films obtained were characterized using scanning electron microscopy (SEM) and energy-dispersion X-ray analysis (EDX). SEM and EDX studies show that the dense and homogeneous silver films could be obtained.

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In recent years, silver has received considerable attention in microelectronics, due to its lowest resistivity and highest thermal conductivity among all metals [1–5]. Further applications include the use of silver in the production of mirrors [6], as component of high-temperature superconducting materials [7], magnetics [8], or bactericidal coatings [9]. The deposition and characterization of Ag layers grown from new precursors therefore becomes an important research topic.

Various methods have been used to deposit silver thin films, such as sputtering [10], thermal evaporation [11], electron-beam evaporation [12], and chemical vapor deposition (CVD) [13]. Of these techniques, Metal Organic Chemical Vapor Deposition (MOCVD) is a very effective technique to produce high quality metal films with high deposition rates, good step coverage and higher aspect ratio in the multilevel metallization structure for the future generation of integrated circuits [14,15].

One of the major problems in silver-MOCVD is the availability of appropriate silver(I) precursors. They should be volatile, generally monomeric, easy to handle during the deposition processes, and storable for a long period of time without decomposition at room temperature. However, to date new silver(I) complexes which can be used as precursors in chemical vapor deposition are still not sufficiently available. In order to search for the new precursors for the growth of silver, we reported here the synthesis of trimethylphosphite stabilized *N*-silver(I) succinimide which were used as precursor for the deposition of silver by using MOCVD techniques. The single crystal structure of **2a** has been determined and discussed as well.

Metal organic silver precursors of type $[(MeO)_3P_n \cdot AgNC_4H_4O_2]$ (n = 1, 2) were prepared [16,17] and used for this work. The solvent, dichloromethane (CH₂Cl₂) was purified by distillation from P₂O₅ under N₂ before use. Compound [AgNC₄H₄O₂] (1) was synthesized by the reaction of succinimide with excessive Ag₂O in boiling water [18]. Complexes were synthesized by the interaction of [AgNC₄H₄O₂] (1) with P(OMe)₃ in stoichiometric ratios in CH₂Cl₂ as shown in Scheme 1.

Complex 2a crystallizes in the monoclinic with space group P2(1)/n, which is composed of a dimer $[(MeO)_3P \cdot AgNC_4H_4O_2]_2$, as shown in Fig. 1 and crystal data with refinement parameters is given in supporting information [19]. Complex **2a** is a dimer where a silver atom is coordinated by a phosphorus atom of P(OMe)₃, a nitrogen and an oxvgen atom from succinimide. The Ag(1)-N(2)-C(5)-O(3)-Ag(2) plane is roughly perpendicular to the Ag(1)-O(1)-C(1)-N(1)-Ag(2) plan with a dihedral angle of 77.3°. Four atoms [O(1), N(2), P(1), Ag(1)] as well as [N(1), O(3), Ag(2), P(2)] are in the same plane, forming an triangle geometry around silver. The structure features a metallophilic Ag-Ag contact of 3.089 between silver atoms which are in a planar threecoordinate configuration. The Ag–O distances [2.470(3), 2.543(3)] are close to that of $[Ag_4PH_4(P(p-tol)_3)_6]$ [2.440(5), 2.480(6)] (PH = C₈H₅-N₂O₂) [20]. The Ag-P bond distances in complex 2a [2.357(7), 2.356(8)] are shorter than the sum of covalent radii of the P and Ag atoms (2.44) [21]. The silver atom and the nitrogen atom of succinimide form Ag-N bonds in complex 2a [2.171(3), 2.142(3)] which are all shorter than that of [(Ph₃P)₃·AgNC₄H₄O₂] [2.313(4)][22]. The angles of O(3)-Ag(2)-N(1) [99.2(3)°] and O(1)-Ag(1)-N(2) [103.3(4)°] are much larger than that of $[Ph_3P \cdot AgO_3SCF_3]$ [90.1(1)°] [23].

ThemoGravimetry (TG) and Differential Scanning Calorimetry (DSC) studies are required to optimize the temperature at which the respective single silver precursor should be maintained during the

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Scheme 1. Synthesis of Complexes 2a - 2b.

CVD experiments. For an example, the TG and DSC curves of complex **2b** are shown in Fig. 2. It can be seen from the DSC curve that there is one apparent endothermic process with the peak temperatures at 107 °C and one continuous exothermic process with the peak temperatures at 185 °C from 89 °C to 319 °C and the silver precursor decomposes in this range. Firstly, it may lose a $P(OEt)_3$ from 89 to 160 °C with corresponding weight loss of about 27.30% which is close to the theoretical loss. It is very difficult to distinguish from one step to another and know the sequence of decomposition of another $P(OEt)_3$ and succinimide. The final percentage of the residue is 25.32%, which is little higher than the theoretical value of silver (23.76%). The thermal measurement is in good agreement with the structural analysis.

CVD experiment using **2b** as precursor was performed in a hotwall reactor using a continuous evaporation system. The deposition of Ag films was carried out in a reaction chamber (a hot-wall vertical cylindrical reactor). The precursor vessel was heated by a heating band. Carrier gas was introduced into the vessel to pick up the



Fig. 1. The crystal structure of 2a. The hydrogen atoms are omitted for clarity. Selected bond lengths (Å) and angles (°): Ag(1)-N(2) 2.171(3), Ag(1)-P(1) 2.357(11), Ag(1)-O(1) 2.470(3), Ag(2)-N(1) 2.142(3), Ag(2)-P(2) 2.356(12), Ag(2)-O(3) 2.357(11), Ag(1)-O(1) 1.217(5), C(1)-O(1) 1.243(4), C(1)-N(1) 1.346(5), C(1)-C(2) 1.507(5), N(1)-C(4) 1.384(5), C(5)-O(3) 1.233(5), C(5)-N(2) 1.359(5), C(5)-C(6) 1.515(6), C(4)-O(2) 1.214(5), C(4)-C(3) 1.520(6), C(7)-C(8) 1.517(6), C(7)-C(6) 1.519(6), C(8)-N(2) 1.372(5), C(2)-C(3) 1.518(6); N(2)-Ag(1)-P(1) 144.4(9), N(2)-Ag(1)-O(1) 103.3(11), P(1)-Ag(1)-O(1) 110.1(8), N(1)-Ag(2)-P(2) 158.9(9), N(1)-Ag(2)-O(3) 99.2(12), P(2)-Ag(2)-O(3) 95.5(9), C(1)-O(1)-Ag(1) 123.5(2), C(5)-O(3)-Ag(2) 129.7(3), O(4)-C(8)-N(2) 125.0(4), O(4)-C(8)-C(7) 124.2(4), N(2)-C(8)-C(7) 110.7(4), O(1)-C(1)-N(1) 124.8(4), O(1)-C(1)-C(2) 122.7(3), N(1)-C(1)-C(2) 112.5(3), C(1)-N(1)-C(4) 109.8(3), C(1)-N(1)-Ag(2) 131.3(3), C(4)-N(1)-Ag(2) 118.7(3), C(5)-N(2)-C(8) 110.2(4), C(5)-N(2)-Ag(1) 122.4(3), C(8)-N(2)-Ag(1) 127.2(3), C(5)-C(6)-C(7) 103.6(4), C(1)-C(2) 103.4(3).

precursor vapor and transport into the reaction zone. The substrate susceptor was in the reactor that can be heated by a resistive heating element. The reaction by-products were exhausted by a pumping system. In a typical CVD experiment silver was deposited onto pieces of a Si substrate at 350 °C. The precursor temperature was maintained at 75 °C with a nitrogen flow at 20 sccm. The run time was 1 h and the total pressure was maintained at 7.0×10^{-4} bar with nitrogen as carrier gas. No reducing agent such as H₂ was used in the deposition processes. The average film thickness was about 0.6 µm, giving a growth rate of 0.6 µm h⁻¹. The surface morphology and composition of the silver were examined by scanning electron microscopy (SEM) and energy-dispersion X-ray analysis (EDX).

The layer deposited is silver colored. SEM (Fig. 3) studies show that the dense and homogeneous silver layer was formed. The film is composed of many well isolated, granular particulates spreading all over the substrate surface. The sizes of silver grains are in the range of 20–40 nm.

The EDX spectrum (Fig. 3) of the deposited film shows Ag as a main component. Next to silver, silicon as substrate component was detected. This is due to the discontinuous Ag particles exposing the substrate and the relatively high penetration depth of the electron beam during the EDX analysis. The other light elements, such as C, O, and P, which might be present as impurities or formed by surface oxidation of silver, are below the detection limit.

In summary, a straightforward synthesis methodology for the preparation of trimethylphosphite stabilized *N*-silver(I) succinimide complexes was described. Complex **2b** was tested as MOCVD precursor for the deposition of silver for the first time. It has been demonstrated that the complex was a promising candidate as precursor for the deposition of Ag.

Acknowledgements





Fig. 2. TG and DSC curves of 2b (heating rate 10 °C min⁻¹, nitrogen atmosphere).



Fig. 3. SEM images showing the morphology and EDX spectrum of the silver deposit obtained from the MOCVD at 350 °C of sample 2b deposited on a Si wafer.

(2009ZX02039101-02), Funding of Jiangsu Innovation Program for Graduate Education (CX10B_100Z), Funding for Outstanding Doctoral Dissertation in NUAA (BCXI10-11).

Appendix A. Supplementary data

Supplementary data to this article can be found online at doi:10.1016/j.inoche.2010.10.014.

References

- [1] P. Piszczek, E. Sylyk, M. Chaberski, C. Taeschner, A. Leonhardt, W. Bala, K. Bartkiewicz, Chem. Vap. Dep. 11 (2005) 53-59.
- K.M. Chi, Y.H. Lu, Chem. Vap. Dep. 7 (2001) 117-120.
- [3] H. Schmidt, Y. Shen, M. Leschke, T. Haase, K. Kohse-Höinghaus, H. Lang, J. Organomet. Chem. 669 (2003) 25-31.
- [4] T.T. Kodas, M.J. Hampden-Smith, The Chemistry of Metal CVD, VCH, Weinheim, Germany, 1994.
- [5] D.R. Smith, F.R. Fickett, J. Res. Natl. Inst. Stand. Technol. 100 (1995) 119-171.
- [6] J. Fraden, Handbook of modern sensors: physics, design and applications, 2nd ednAmerican Institute of Physics, 1997.
- [7] A. Jakob, H. Schmidt, P. Djiele, Y.Z. Shen, H. Lang, Microchim. Acta 156 (2007) 77-81.
- Y.F. Lu, M. Takai, S. Nagatomo, K. Kato, S. Namba, Appl. Phys. A Mater. Sci. Process [8] 54 (1992) 51-56.
- [9] H. Liedberg, T. Lundeberg, Urol. Res. 17 (1989) 359-360.
- [10] M. Hauder, W. Hansch, J. Gstootner, D. Schmitt-Landsiedel, Appl. Phys. Lett. 78 (2001) 838-840.
- [11] J. Uchil, K. Mohan Rao, M. Pattabi, J. Phys. D Appl. Phys. 29 (1996) 2992-2996.
- [12] A.C. Carter, W. Chang, S.B. Qadri, J.S. Horwitz, R. Leuchtner, D.B. Chrisey, J. Mater. Res. 13 (1998) 1418-1421.
- [13] A. Grodzicki, I. Lakomska, P. Piszczek, I. Szymanska, E. Szlyk, Coord. Chem. Rev. 249 (2005) 2232-2258.

- [14] W. Zhang, S.H. Brongersma, O. Richard, B. Brijs, R. Palmans, L. Froyen, K. Maex, Microelectron. Eng. 76 (2004) 146-152.
- L. Gao, P. Harter, C. Linsmeiner, A. Wiltner, R. Emling, D.S. Landsied, Microelectron. [15] Eng. 82 (2005) 296-300.
- [16] Complex 2a was obtained by N-silver(I) succinimide (0.1379 g, 0.67 mmol) with trimethylphosphite (0.1661 g, 1.34 mmol) in CH2Cl2 at 0°C. A white solid product was obtained after removing all volatiles in oil-pump vacuo, Yield: 0.29 g (95% based on N-silver(I) succinimide). Mp.: 170 °C dec. Anal. calcd. for C14H26O10Ag2P2N2: C, 25.48; H, 3.97. Found: C, 25.39; H, 3.83. 1 H NMR (CDCl3, 500 MHZ, ppm): & 2.61 (s, 4 H, CH2-H), 3.66-3.68 (d, 9 H, CH3O-H, JPH = 12.6 Hz). 13 C{H} NMR (CDCl3, 125 MHZ, ppm): δ 32.1 (CH2), 51.3 (CH3/ CH3O-), δ 191.6 (C=O). IR (KBr) data (cm-1): 3437 (m), 3285 (m), 2939 (m), 2839 (w), 1701 (m), 1618 (s), 1439 (m), 1359 (s), 1269 (s), 1249 (s), 1182 (m), 1012 (s), 790 (m), 761 (m), 669 (m), 571 (w), 526 (m), 451 (m). 31P{H} NMR (CDCl3, 121 MHZ, ppm): 8 126.8.
- [17] Complex 2b was synthesized by N-silver(I) succinimide (0.1132 g, 0.55 mmol) with trimethylphosphite (0.2046 g, 1.65 mmol). After appropriate work-up, complex 2b was obtained as a colourless liquid. Yield: 0.29 g (91% base on N-silver(I) succinimide). Anal. calcd. for C10H22O8AgP2N: C, 26.45; H, 4.88. Found: C, 26.31; H, 4.73. 1 H NMR (CDCl3, 500 MHZ, ppm): 8 2.62 (s, 4 H, CH2-H), 3.64-3.66 (d, 18 H, CH3O-H, JPH = 12.1 Hz). 13 C{H} NMR (CDCl3, 125 MHZ, ppm): δ 32.3 (CH2), δ 50.7 (JPC=5.5 Hz, CH3/CH3O-), δ 192.1 (C=O). IR (KBr) data (cm-1): 3458 (m), 2952 (m), 2843 (s), 1710 (m), 1590 (s), 1439 (m), 1352 (s), 1291 (s), 1250 (s), 1183 (m), 1013 (s), 793 (m), 675 (m), 523 (m), 450 (m). 1P{H} NMR (CDCl3, 121 MHZ, ppm): δ 134.4.
- [18] J. Perron, A.L. Beauchamp, Inorg. Chem. 23 (1984) 2853-2859.
- [19] Crystal data for [(MeO)3P·AgNC4H4O2]2, F.wt. = 660.05, T = 293(2) K, Monoclinic, space group P2(1)/n, a=13.982(17) Å, b=9.606(11) Å, c=18.054(19) Å, $\alpha = 90.00^{\circ} \beta = 104.11(7)^{\circ} \gamma = 90.00^{\circ} V = 2351.7(5) \text{ Å}3, Z = 4, D = 1.864 \text{ mg/m3},$ $\mu = 1.85 \text{ mm-1}$, F(000) = 1312, R1 [I>2 σ (I)] = 0.0492, wR2 [I>2 σ (I)] = 0.0840, R1 = 0.0584, wR2 = 0.0872 (all data).
- [20] D.R. Whitcomb, M. Rajeswaran, J. Chem. Crytallogr. 36 (2006) 587-598.
- [21] B.K. Teo, J.C. Calabrese, Inorg. Chem. 15 (1976) 2467-2474
- X. Tao, Y.Q. Li, H.H. Xu, N. Wang, F.L. Du, Y.Z. Shen, Polyhedron 28 (2009) [22] 1191-1195.
- A. Codina, O. Crespo, E.J. Fernández, P.G. Jones, A. Laguna, J.M. López-de-Luzuriaga, [23] M.E. Olmos, Inorg. Chim. Acta 347 (2003) 9-15.